

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10551817	LIN ET AL.
	Examiner	Art Unit
	Cheng, Ichieh	4183

SEARCHED			
Class	Subclass	Date	Examiner
455	452.1-452.2	7/29/2008	SR
370	310.1,331,338	7/29/2008	SR

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST	7/29/2008	SR	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner